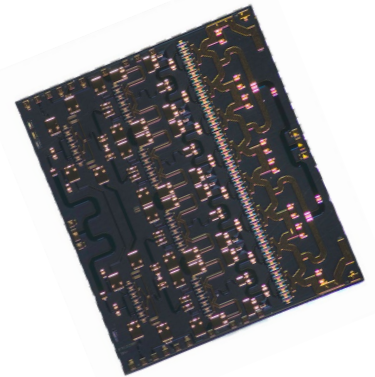


# CMPA1C1D060D

60 W, 12.7 - 13.25 GHz, 40 V, GaN MMIC, Power Amplifier

Cree's CMPA1C1D060D is a gallium nitride (GaN) High Electron Mobility Transistor (HEMT) based monolithic microwave integrated circuit (MMIC) on a silicon carbide substrate, using a 0.25  $\mu\text{m}$  gate length fabrication process. GaN-on-SiC has superior properties compared to silicon, gallium arsenide or GaN-on-Si, including higher breakdown voltage, higher saturated electron drift velocity and higher thermal conductivity. GaN HEMTs also offer greater power density and wider bandwidths compared to Si, GaAs, and GaN-on-Si transistors.



## Typical Performance Over 12.7-13.25 GHz ( $T_c = 25^\circ\text{C}$ )

Parameter	12.7 GHz	13.0 GHz	13.25 GHz	Units
Small Signal Gain	26.5	26.2	26	dB
$P_{SAT} @ P_{IN} = 28 \text{ dBm}$	65	63	60	W
$PAE @ P_{IN} = 28 \text{ dBm}$	29	28	27	%

**Note:** All data in this table is based on fixtured, CW performance.

### Features

- 26 dB Small Signal Gain
- 60 W Typical  $P_{SAT}$
- Operation up to 40 V
- High Breakdown Voltage
- High Temperature Operation
- Size 0.209 x 0.240 x 0.004 inches

### Applications

- Satellite Communications Uplink
- PTP Radio

## Absolute Maximum Ratings (not simultaneous) at 25°C

Parameter	Symbol	Rating	Units	Conditions
Drain-source Voltage	$V_{DSS}$	84	$V_{DC}$	25°C
Gate-source Voltage	$V_{GS}$	-10, +2	$V_{DC}$	25°C
Storage Temperature	$T_{STG}$	-55, +150	°C	
Operating Junction Temperature	$T_J$	225	°C	
Maximum Forward Gate Current	$I_{GMAX}$	16.8	mA	25°C
Maximum Drain Current <sup>1</sup>	$I_{DMAX}$	1.8	A	Stage 1, 25°C
Maximum Drain Current <sup>1</sup>	$I_{DMAX}$	3.6	A	Stage 2, 25°C
Maximum Drain Current <sup>1</sup>	$I_{DMAX}$	9	A	Stage 3, 25°C
Thermal Resistance, Junction to Case <sup>2</sup>	$R_{\theta JC}$	1.12	°C/W	85°C, $P_{DISS} = 118$ W
Mounting Temperature (30 seconds)	$T_S$	320	°C	30 seconds

Note<sup>1</sup> Current limit for long term, reliable operation. Total current when biased from top and bottom drain pads.

Note<sup>2</sup> Eutectic die attach using 80/20 AuSn mounted to a 55 mil thick CuMoCu carrier.

## Electrical Characteristics (Frequency = 12.7 GHz to 13.25 GHz unless otherwise stated; $T_C = 25^\circ\text{C}$ )

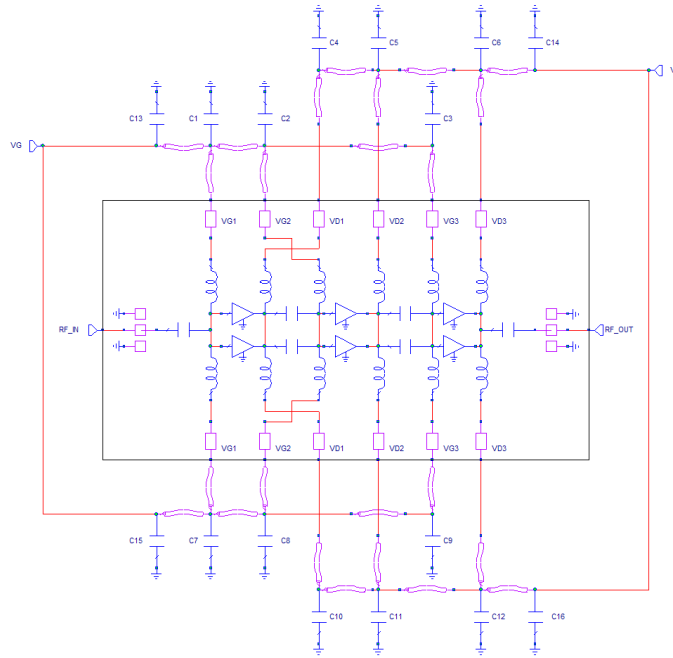
Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
<b>DC Characteristics</b>						
Gate Threshold	$V_{TH}$	-3.8	-2.8	-2.3	V	$V_{DS} = 10$ V, $I_D = 27$ mA
Drain-Source Breakdown Voltage	$V_{BD}$	84	100	-	V	$V_{GS} = -8$ V, $I_D = 27$ mA
<b>RF Characteristics<sup>2</sup></b>						
Small Signal Gain	S21	-	27	-	dB	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A
Input Return Loss	S11	-	-15	-	dB	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A
Output Return Loss	S22	-	-5	-	dB	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A
Power Output	$P_{OUT}$	-	75	-	W	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A, CW, $P_{IN} = 30$ dBm
Power Added Efficiency	PAE	-	30	-	%	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A, CW, $P_{IN} = 30$ dBm
Power Gain	$G_p$	-	19	-	dB	$V_{DD} = 40$ V, $I_{DQ} = 0.45$ A, CW, $P_{IN} = 30$ dBm
Output Mismatch Stress	VSWR	-	5:1	-	$\Psi$	No damage at all phase angles, $V_{DD} = 40$ V, $I_{DQ} = 0.45$ A, $P_{OUT} = 30$ W CW

### Notes:

<sup>1</sup> Scaled from PCM data.

<sup>2</sup> All data pulse tested on-wafer with Pulse Width = 10  $\mu\text{s}$ , Duty Cycle = 0.1%.

## Block Diagram Showing Additional Capacitors for Operation Over 12.7 to 13.25 GHz



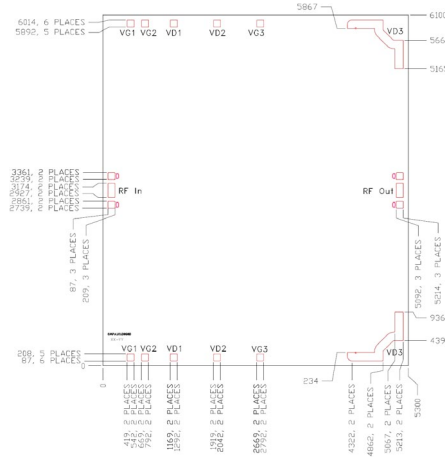
Designator	Description	Quantity
C1,C2,C3,C4,C5,C6,C7,C8,C9,C10,C11,C12	CAP, 51pF, +/-10%, SINGLE LAYER, 0.030", Er 3300, 100V, Ni/Au TERMINATION	12
C13,C14,C15,C16	CAP, 680pF, +/-10%, SINGLE LAYER, 0.070", Er 3300, 100V, Ni/Au TERMINATION	4

### Notes:

<sup>1</sup> The input, output and decoupling capacitors should be attached as close as possible to the die- typical distance is 5 to 10 mils with a maximum of 15 mils.

<sup>2</sup> The MMIC die and capacitors should be connected with 2 mil gold bond wires.

## Die Dimensions (units in microns)



Overall die size 5300 x 6100 (+0/-50) microns, die thickness 100 (+/-10) microns.  
All Gate and Drain pads must be wire bonded for electrical connection.

Pad Number	Function	Description	Pad Size (in)	Note
1	RF_IN	RF-Input pad. Matched to 50 ohm	125x250	3
2	VG1 bottom	Gate control for stage1. Vg = -2.0 to -3.5 V	125x125	1,2
3	VG1 top	Gate control for stage1. Vg = -2.0 to -3.5 V	125x125	1,2
4	VG2 bottom	Gate control for stage2. Vg = -2.0 to -3.5 V	125x125	1,2
5	VG2 top	Gate control for stage2. Vg = -2.0 to -3.5 V	125x125	1,2
6	VD1 bottom	Drain control for stage1. Vd = 40 V	125x125	1
7	VD1 top	Drain control for stage1. Vd = 40 V	125x125	1
8	VD2 bottom	Drain control for stage2. Vd = 40 V	125x125	1
9	VD2 top	Drain control for stage2. Vd = 40 V	125x125	1
10	VG3 bottom	Gate control for stage3. Vg = -2.0 to -3.5 V	125x125	1,2
11	VG3 top	Gate control for stage3. Vg = -2.0 to -3.5 V	125x125	1,2
12	VD3 bottom	Drain control for stage3. Vd = 40 V	540x150	1
13	VD3 top	Drain control for stage3. Vd = 40 V	150x500	1
14	RF_OUT	RF-Output pad. Matched to 50 ohm	125x250	3

### Notes:

<sup>1</sup> Attach bypass capacitor to pads 2-13 per applications circuit

<sup>2</sup> VG1&2&3 top and bottom are connected internally, so it would be enough to connect either one for proper operation

<sup>3</sup> The RF Input and Output pads have a ground-signal-ground with a nominal pitch of 10 mil (250 um). The RF ground pads are 125 x 250 microns

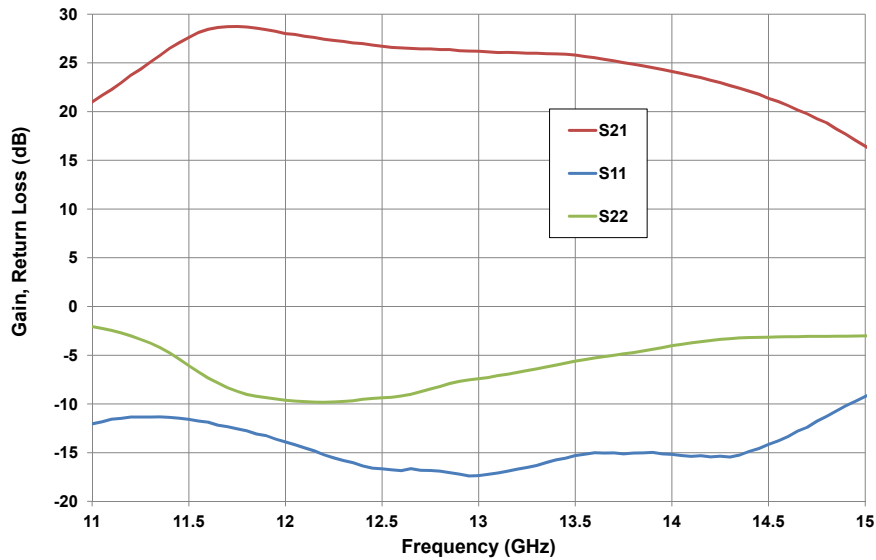
### Die Assembly Notes:

- Recommended solder is AuSn (80/20) solder. Refer to Cree's website for the Eutectic Die Bond Procedure application note at <http://www.cree.com/~media/Files/Cree/RF/Application%20Notes/Appnote%20%20Eutectic.pdf>
- Vacuum collet is the preferred method of pick-up.
- The backside of the die is the Source (ground) contact.
- Die back side gold plating is 5 microns thick minimum.
- Thermosonic ball or wedge bonding are the preferred connection methods.
- Gold wire must be used for connections.
- Use the die label (XX-YY) for correct orientation.

## Typical Performance of the CMPA1C1D060D

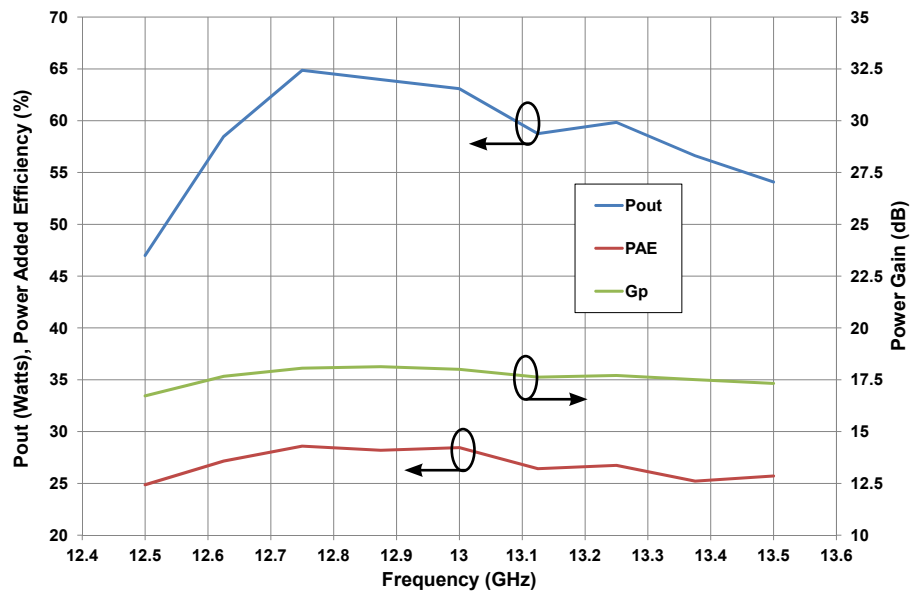
### Small Signal Gain vs Frequency

$V_{DD} = 40\text{ V}$ ,  $I_{DQ} = 0.45\text{ A}$

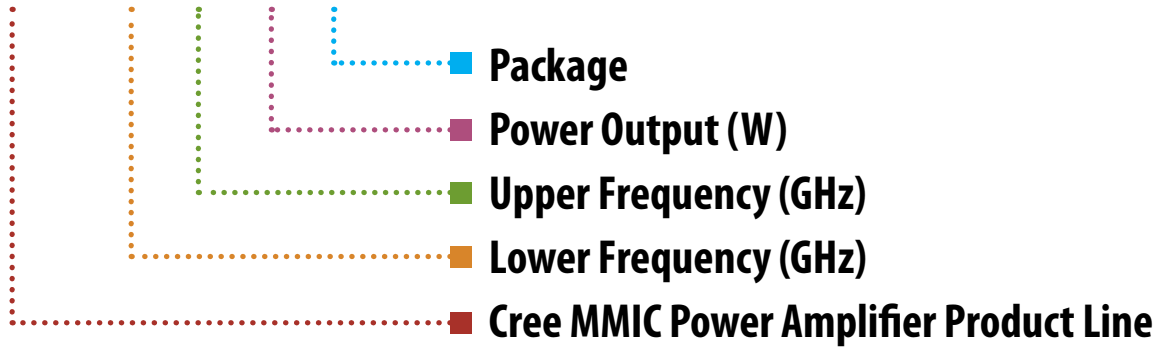


### Output Power & PAE vs Frequency

$V_{DD} = 40\text{ V}$ ,  $I_{DQ} = 0.45\text{ A}$ ,  $P_{IN} = 28\text{ dBm}$



# CMPA1C1D060D



Parameter	Value	Units
Lower Frequency	12.7	GHz
Upper Frequency <sup>1</sup>	13.25	GHz
Power Output	60	W
Package	Bare Die	-

Table 1.

**Note<sup>1</sup>:** Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value
A	0
B	1
C	2
D	3
E	4
F	5
G	6
H	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

Table 2.



## Product Ordering Information

Order Number	Description	Unit of Measure
CPA1C1D060D	GaN MMIC, Bare Die	Each



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